IFW)

03500.109446.

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)
MASAKI MIZUTANI, et al.	:) Crosse Art Unit: 2813
Application No.: 10/563,115	: Group Art Unit: 2812
Intl. Filing Date: May 17, 2005)
371(c) Date: January 3, 2006)
For: SILICON LAYER PRODU METHOD AND SOLAR C PRODUCTION METHOD	•

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

<u>INFORMATION DISCLOSURE STATEMENT</u>

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449.

The Examiner's attention is also directed to the following U.S. Application:

Application No.	U.S. Filing Date	Applicants
10/976,853	11/01/2004	T. Yoshino S. Nishida

This Information Disclosure Statement is being filed before the issuance of a

first Office Action on the merits. Therefore, no fee under 37 C.F.R. § 1.97(c)(2) is believed

due. Nevertheless, the Commissioner may charge Deposit Account No. 06-1205, should

any fee be due for filing this paper.

Applicants request that the above information be considered by the

Examiner and that a copy of the enclosed Form PTO-1449 be initialed and returned

indicating that such information has been considered.

Applicants' undersigned attorney may be reached in our Costa Mesa,

California office at (714) 540-8700. All correspondence should continue to be directed to

our below-listed address.

Respectfully submitted,

Damond E. Vadnais

Attorney for Applicants Registration No.: 52,310

FITZPATRICK, CELLA, HARPER & SCINTO

30 Rockefeller Plaza

New York, New York 10112-3800

Facsimile: (212) 218-2200

- 2 -

FORM PTO 1449 (modified)		ATTY DOCKET NO. 03500.109446.	APPLICATION NO. 10/563,115			
U.S. DEPARTMENT OF COMMERCE PE PATENT AND TRADEMARK OFFICE PE LIST OF REFERENCES CITED BY APPLICANT(S)						
(Use several sheets if necessary) MAY 0 1 2007		371(c) DATE January 3, 2006		GROUP 2812		
	(3)	THAUE MET	U.S. PATENT DOCUMENTS			
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
	7,118,625	10/10/06	Nishida, et al.	117	54	
	7,022,181	04/04/06	Nakagawa, et al.	117	54	
	6,953,506	10/11/05	lwane, et al.	117	206	
	6,869,863	03/22/05	Nishida	438	497	
	6,824,609	11/30/04	Saito, et al.	117	54	
	6,818,104	11/16/04	lwasaki, et al.	204	199	
	6,802,926	10/12/04	Mizutani, et al.	156	247	
	6,802,900	10/12/04	lwane, et al.	117	54	
	6,756,289	06/29/04	Nakagawa, et al.	438	478	
	6,682,990	01/27/04	lwane, et al.	438	458	-
	6,664,169	12/16/03	lwasaki, et al.	438	409	
	6,566,277	05/20/03	Nakagawa, et al.	438	761	
	6,566,235	05/20/03	Nishida, et al.	438	458	
	6,500,731	12/31/02	Nakagawa, et al.	438	455	
	6,464,762	10/15/02	Arao	106	1.22	
	6,452,091	09/17/02	Nakagawa, et al.	136	261	
	6,429,035	08/06/02	Nakagawa, et al.	438	57	
	6,391,743	05/21/02	lwane, et al.	438	458	
	6,387,780	05/14/02	Nishida	438	497	
	6,384,313	05/07/02	Nakagawa, et al.	136	244	
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER			DATE CONSIDERED			

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMPENCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 03500.109446.	APPLICATION NO.	10/563,115		
		APPLICANT MASAKI MIZUTANI, et al.				
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(000	\	A.I	371(c) DATE January 3, 20	06	GROUP	2812
	73		U.S. PATENT DOCUMENTS			
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	6,331,208	12/18/01	Nishida, et al.	117	89	-
	6,258,698	07/10/01	lwasaki, et al.	438	455	
	6,258,666	07/10/01	Mizutani, et al.	438	258	
	6,248,948	06/19/01	Nakagawa, et al.	136	244	
	6,211,038	04/03/01	Nakagawa, et al.	438	409	
	6,190,937	02/20/01	Nakagawa, et al.	438	67	
	6,110,347	08/29/00	Arao, et al.	205	333	
	5,986,204	11/16/99	lwasaki, et al.	136	256	
	5,981,864	11/09/99	Mizutani, et al.	136	244	
	5,770,463	06/23/98	Nakagawa, et al.	437	2	
	5,714,010	02/03/98	Matsuyama, et al.	118	723	
	5,712,199	01/27/98	Nakagawa, et al.	438	62	
	5,510,151	04/23/96	Matsuyama, et al.	427	509	
	5,486,238	01/23/96	Nakagawa, et al.	136	259	
	2006/0194417	08/31/06	Ishihara, et al.	438	479	
	2005/0109388	05/26/05	Murakami, et al.	136	255	<u></u>
	2005/0087226	04/28/05	Nishida, et al.	136	256	
FOREIGN PATENT DOCUMENTS						
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